Explore the very small with Xenocs solutions

Xenocs is proud to introduce you to their solutions for **characterizing nanostructures.** Using Small and Wide Angle X-ray Scattering techniques, the Xenocs solution combines unique ergonomics, ease-of-use and unparalleled performance.



Nano-inXider, SAXS made easy

Xeuss 2.0, the SAXS/WAXS laboratory beamline

Our mission : to provide solutions for nanoscale characterization of materials

With over 17 years of acknowledged expertise in X-ray technology, Xenocs provides cutting edge solutions in nanocharacterization. Strengthened by a worldwide distribution network, our team of experts is committed to answering your individual needs.

